Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/777,653	WU ET AL.		
Examiner	Art Unit		
Phallaka Kik	2825		

SEARCHED					
Class	Subclass	Date	Examiner		
716	11,3,7	1/21/2006	PK		
Above	New	1/23/2006	PK		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
716	11,3,7	1/24/2006	PK		
USPGPUB (see attached)		1/24/2006	PK		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
BRS (EAST)USPAT, USPGPUB Cls/Sub searched: 716/1-18 (see attached)	1/21/2006	PK		
Consulted with Examiner Vuthe Sieksuggested search in class 716 for signal name based databases use for schematic linking.	1/23/2006	PK		
Above New Search Additional Cls/Sub searched: 703/14-16; 707/3-6,102,200-204 (see attached)	1/23/2006	PK		
-EPO, JPO, IBM TDB, Derwent (see attached)	1/21/2006	PK		
-EPO, JPO, IBM TDB, Derwent (see attached)	1/23/2006	PK		
IEE/IEEE Xplore (see attached)	1/21/2006	PK		